Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination DAVIES ET AL.	
10/713,636		
Examiner	Art Unit	
IVOTHSNA A VENKAT Ph	1615	

SEARCHED						
Class	Subclass	Date	Examiner			
		- 1				
	<u> </u>	-				

INTERFERENCE SEARCHED							
Class	Subclass	Date	Exampler				
424	70-1	2/25/00	W				
	706	1 1					
	70.12	¥	1				

	SEARCH NOTES					
	(INCLUDING SEARCH)			
		DATE	EXMR			
	especiated host	12/200	2			
	1 of	De pour	0			
	MOST					
	, 1					
/	Interference					
	may row is	V	V			
	seanch					
	· To it Administra					
	•					
		_				